RESPONSE UNDER 37 CFR 1.116
EXPEDITED PROCEDURE
EXAMINING GROUP 2655
Attorney Docket No. 1793.1052

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of:

Kyung-geun Lee, et al.

Application No. 10/678,633 Group Art Unit: 2655

Confirmation No. 7810

Filed: October 6, 2003 Examiner: Tan X. Dinh

For: OPTICAL STORAGE MEDIUM HAVING TEST PATTERN FOR MEASURING A MODULATION DEGREE DURING RECORDING PROCESS

AMENDMENT AFTER FINAL

Mail Stop: **AF**
Commissioner for Patents
PO Box 1450
Alexandria, VA 22313-1450

Sir:

This is in response to the Office Action mailed June 5, 2007, and having a period for response set to expire on September 5, 2007.

The following amendments and remarks are respectfully submitted. Reconsideration of the claims is respectfully requested.